

Search Notes

Application/Control No.

10/642,291

Examiner

John S. Chu

Applicant(s)/Patent under
Reexamination

YASUNAMI ET AL.

Art Unit

1752

SEARCHED

Class	Subclass	Date	Examiner
430	270.1	1/2007	JSC
430	905		
430	910		
430	325		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST SEARCH IN FILE	1/2007	JSC